

# **SNx4AC08 Quadruple 2-Input Positive-AND Gates**

#### 1 Features

- 2V to 6V  $V_{CC}$  operation
- Inputs accept voltages to 6V
- Max t<sub>pd</sub> of 7.5ns at 5V

# 2 Description

The 'AC08 devices are quadruple 2-input positive-AND gates. These devices perform the Boolean function  $Y = A \cdot B$  in positive logic.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE(2)	BODY SIZE(3)
	DB (SSOP, 14)	6.2mm x 7.8mm	6.2mm x 5.3mm
	D (SOIC, 14)	8.65mm x 6mm	8.65mm x 3.9mm
SNx4AC08	N (PDIP, 14)	19.3mm x 9.4mm	19.3mm x 6.35mm
	NS (SO, 14)	10.2mm x 7.8mm	10.3mm x 5.3mm
	PW (TSSOP, 14)	5mm x 6.4mm	5mm x 4.4mm

- For more information, see Section 10.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.





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# 3 Pin Configuration and Functions

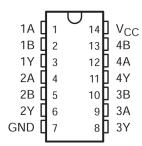
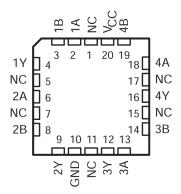


Figure 3-1. SN54AC08 J or W Package; SN74AC08 D, DB, N, NS, or PW Package (Top View)



NC - No internal connection

Figure 3-2. SN54AC08 FK Package (Top View)

**Table 3-1. Pin Functions** 

PIN				
NAME	D, N, NS, PW, J, or W	FK	I/O	DESCRIPTION
1A	1	2	Input	Channel 1, Input A
1B	2	3	Input	Channel 1, Input B
1Y	3	4	Output	Channel 1, Output Y
2A	4	6	Input	Channel 2, Input A
2B	5	8	Input	Channel 2, Input B
2Y	6	9	Output	Channel 2, Output Y
GND	7	10	_	Ground
3Y	8	12	Output	Channel 3, Output Y
3A	9	13	Input	Channel 3, Input A
3B	10	14	Input	Channel 3, Input B
4Y	11	16	Output	Channel 4, Output Y
4A	12	18	Input	Channel 4, Input A
4B	13	19	Input	Channel 4, Input B
V <sub>CC</sub>	14	20	_	Positive Supply
NC		1, 5, 7, 11, 15, 17	_	Not internally connected



# 4 Specifications

# 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
V <sub>I</sub> (2)	Input voltage range		-0.5	V <sub>CC</sub> + 0.5	V
V <sub>O</sub> <sup>(2)</sup>	Output voltage range		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	$(V_I < 0 \text{ or } V_I > V_{CC})$		±20	mA
I <sub>OK</sub>	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA
Io	Continuous output current	$(V_O = 0 \text{ to } V_{CC})$		±50	mA
	Continuous current through V <sub>CC</sub> or GNI	D		±200	mA
T <sub>stg</sub>	Storage temperature range			150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 4.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

	<u> </u>		SN54AC0	8	SN74AC	08	LINUT
			MIN	MAX	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	6	2	6	V
		V <sub>CC</sub> = 3V	2.1		2.1		
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 4.5V	3.15		3.15		V
		V <sub>CC</sub> = 5.5V	3.85		3.85		
		V <sub>CC</sub> = 3V		0.9		0.9	
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 4.5V		1.35		1.35	V
		V <sub>CC</sub> = 5.5V		1.65		1.65	
VI	Input voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
Vo	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 3 V		-12		-12	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 4.5 V		-24		-24	mA
		V <sub>CC</sub> = 5.5 V		-24		-24	
		V <sub>CC</sub> = 3 V		12		12	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 4.5 V		24		24	mA
		V <sub>CC</sub> = 5.5 V		24		24	
Δt/Δν	Input transition rise or fall rate			8		8	ns/V
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

#### 4.3 Thermal Information

				SNx4AC08			
	THERMAL METRIC(1)	D (SOIC)	DB (SSOP)	N (PDIP)	NS (SOP)	PW (TSSOP)	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	119.9	96	80	76	145.7	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Product Folder Links: SN54AC08 SN74AC08

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



#### 4.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

		-			= 25°C		SN54/	AC08	SN74/	AC08			
PARAMETER	TEST CON	DITIONS	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT		
			3V	2.9		2.9 2.9							
	I <sub>OH</sub> = -50 μA		4.5V	4.4			4.4		4.4				
			5.5V	5.4			5.4		5.4				
V <sub>OH</sub>	$I_{OH} = -12 \text{ mA}$		3V	2.56			2.4		2.46		V		
VOH	I <sub>OH</sub> = −24 mA		4.5V	3.86			3.7		3.76		V		
	10H = 24 IIIA		5.5V	4.86			4.7		4.76				
	$I_{OH} = -50 \text{ mA}^{(1)}$		5.5V				3.85						
	$I_{OH} = -75 \text{ mA}^{(1)}$		5.5V						3.85				
			3V		0.002	0.1		0.1		0.1			
	$I_{OL}$ = 50 $\mu A$		4.5V		0.001	0.1		0.1		0.1			
			5.5V		0.001	0.1		0.1		0.1			
V <sub>OL</sub>	$I_{OL}$ = 12 mA		3V			0.36		0.5		0.44	V		
V OL	I <sub>OL</sub> = 24 mA		4.5V			0.36		0.5		0.44	V		
	10L - 24 IIIA		5.5V			0.36		0.5		0.44			
	$I_{OL} = 50 \text{ mA}^{(1)}$		5.5V					1.65					
	$I_{OL} = 75 \text{ mA}^{(1)}$		5.5V							1.65			
I <sub>I</sub> A or B ports	$V_I = V_{CC}$ or GND		5.5V			±0.1		±1		±1	μΑ		
Icc	$V_I = V_{CC}$ or GND,	<sub>O</sub> = 0	5.5V			2		40		20	μΑ		
Ci	VI = V <sub>CC</sub> or GND		5V		4.5						pF		

<sup>(1)</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

### 4.5 Switching Characteristics, $V_{CC} = 3.3V \pm 0.3V$

over recommended operating free-air temperature range,  $V_{CC}$  = 3.3V  $\pm$  0.3V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	1	T <sub>A</sub> = 25°	C	SN54	AC08	SN74/	AC08	UNIT
PARAMETER	FROW (INFOT)	10 (001701)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	ONII
t <sub>PLH</sub>	A or B	V	1.5	7.5	9.5	1	12.5	1	10	ne
t <sub>PHL</sub>	AUID	T	1.5	7	8.5	1	11.5	1	9	ns

# 4.6 Switching Characteristics, $V_{CC} = 5V \pm 0.5V$

over recommended operating free-air temperature range,  $V_{CC} = 5V \pm 0.5V$  (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	EDOM (INDUT)	TO (OUTDUT)	T,	_ = 25°C		SN54A	C08	SN74A	C08	UNIT
PARAMETER	FROM (INPUT)	то (оитрит)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
t <sub>PLH</sub>	A or B	V	1.5	5.5	7.5	1	9	1	8.5	ns
t <sub>PHL</sub>	AUID	<b>,</b>	1.5	5.5	7	1	8.5	1	7.5	115

# 4.7 Operating Characteristics

 $V_{CC}$  = 5 V,  $T_A$  = 25°C

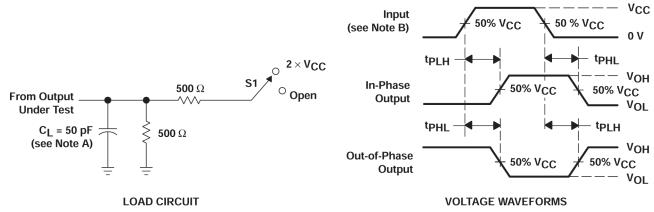
100	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	C <sub>L</sub> = 50 pF, f = 1 MHz	20	pF

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# **5 Parameter Measurement Information**



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_0$  = 50  $\Omega$ ,  $t_r$  v 2.5 ns,  $t_f$  v 2.5 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 5-1. Load Circuit and Voltage Waveforms

TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open

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# **6 Detailed Description**

# **6.1 Functional Block Diagram**



Figure 6-1. Logic Diagram, Each Gate (Positive Logic)

# **6.2 Device Functional Modes**

**Table 6-1. Function Table (Each Gate)** 

INPUTS	3	OUTPUT Y
Α	В	OUTFULL
Н	Н	Н
L	X	L
X	L	L

# 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

# 7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

#### 7.2 Layout

### 7.2.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.

#### 7.2.2 Layout Example

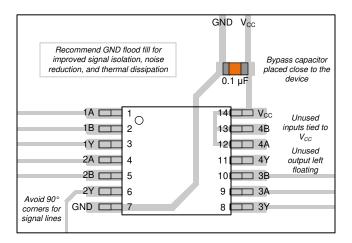


Figure 7-1. Example layout for the SN74AC08

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# 8 Device and Documentation Support

### 8.1 Documentation Support (Analog)

#### 8.1.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54AC08	Click here	Click here	Click here	Click here	Click here	
SN74AC08	Click here	Click here	Click here	Click here	Click here	

### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 8.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

#### 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from Revision D (October 2003) to Revision E (July 2024)

Page

# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-87615012A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87615012A SNJ54AC 08FK	Samples
5962-8761501CA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761501CA SNJ54AC08J	Samples
5962-8761501DA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761501DA SNJ54AC08W	Samples
SN74AC08D	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-40 to 85	AC08	
SN74AC08DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC08	Samples
SN74AC08DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC08	Samples
SN74AC08N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74AC08N	Samples
SN74AC08NSR	ACTIVE	SOP	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC08	Samples
SN74AC08PW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	AC08	
SN74AC08PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC08	Samples
SN74AC08PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC08	Samples
SNJ54AC08FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87615012A SNJ54AC 08FK	Samples
SNJ54AC08J	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761501CA SNJ54AC08J	Samples
SNJ54AC08W	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761501DA SNJ54AC08W	Samples

<sup>(1)</sup> The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.



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(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54AC08. SN74AC08:

Catalog: SN74AC08

Automotive: SN74AC08-Q1, SN74AC08-Q1

Enhanced Product: SN74AC08-EP, SN74AC08-EP

Military: SN54AC08

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product



# **PACKAGE OPTION ADDENDUM**

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- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications



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### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AC08DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74AC08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AC08DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74AC08NSR	SOP	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74AC08PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC08PWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC08PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AC08PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AC08DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74AC08DR	SOIC	D	14	2500	356.0	356.0	35.0
SN74AC08DR	SOIC	D	14	2500	353.0	353.0	32.0
SN74AC08NSR	SOP	NS	14	2000	356.0	356.0	35.0
SN74AC08PWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74AC08PWR	TSSOP	PW	14	2000	353.0	353.0	32.0
SN74AC08PWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74AC08PWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0

# **PACKAGE MATERIALS INFORMATION**

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### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-87615012A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-8761501DA	W	CFP	14	25	506.98	26.16	6220	NA
SN74AC08N	N	PDIP	14	25	506	13.97	11230	4.32
SN74AC08N	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54AC08FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54AC08W	W	CFP	14	25	506.98	26.16	6220	NA

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
   Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
   Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



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